Se	earch	Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination
10/726,902	ALSUP ET AL.
Examiner	Art Unit
Robert E. Fennema	2183

SEARCHED			
	- JEAN		r
Class	Subclass	Date	Examiner
712	207	2/14/2006	RF
		-	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NO (INCLUDING SEARCH		
	DATE	EXMR
EAST (see search notes)	2/14/2006	RF
ACM (see attached example search page)	2/16/2006	RF
Consulted with Primary Examiner Richard Ellis	2/16/2006	ŔF